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<b>Search Notes</b> 		<b>Application/Control No.</b> 10/532,229		<b>Applicant(s)/Patent under Reexamination</b> CHAOUCHE ET AL.	
		<b>Examiner</b> Diem Tran		<b>Art Unit</b> 3748	

SEARCHED			
Class	Subclass	Date	Examiner
60	278	5/25/06	DT
	285		
	286		
	295		
↓	301	↓	↓
updated search		9/29/06	DT
updated search		3/26/07	DT
updated search		9/10/07	DT

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR